

<b>Search Notes</b> 				<b>Application/Control No.</b> 10/617,113 <b>Examiner</b> Leslie Pascal	<b>Applicant(s)/Patent under Reexamination</b> CHOWN, DAVID <b>Art Unit</b> 2613	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
398	135-139	11/7/2006	LP	see search notes	11/6/2007	LP
398	22	6/26/2007	LP	see search notes	6/26/2007	LP
<b>INTERFERENCE SEARCHED</b>				<b> </b>		
Class	Subclass	Date	Examiner			
SEE SEARCH NOTES		2/24/2007	LP			